

MHF® I Connector with Lock

Part No. Plug: 20351-112R-37

Receptacle: 20279-001E-** / 20431-001E-01 / 20441-001E-01

Lock part:3376-000*

Test Report

Product Specification no. PRS-2396

1	T22022	January 21, 2022	S.Taguchi	-	M.Takemoto
0	T20071	September 11, 2020	J.Tonai		M.Takemoto
Rev.	ECN	Date	Prepared by	Checked by	Approved by

1. Purpose

To evaluate the performance of MHF I Connector with LockConnector in accordance with PRS-2396.

2. Specimen

- (1) MHF I PLUG ASS'Y (Part No. 20351-112R-37)
- (2) LOCK (Part No. 3376-000*)
- (3) MHF I/II RECEPTACLE ASS'Y (Part No. 20279-001E-0*)

3. Test Sequence

All the evaluations were performed in accordance with Table 1. Test Sequence.

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See Table 1 to 2, Graph 1 to 10. For the details of the testing conditions and requirements, see PRS-2396.

5. Conclusion

All the specimens met the requirements of PRS-2396.

5-1 Test Sequence and Sample Quantity

Table.1 Test Sequence and Sample Quantity

Toot Itom	1	Iai	JIE. I I	31 351	uence	and S	ample								
Test Item	A	В	С	D	Е	F	G	Group H	J	K	L	М	N	Р	Q
Contact resistance		D	O	D	<u> </u>	1,3	1,3	1,3	1,3	1,4	1,4	1,3	1,3	'	Q
Insulation resistance										2,5	2,5				
Dielectric Withstanding Voltage	1														
VSWR		1													
Un-mating force <unlock state=""></unlock>			1												
Un-mating force <lock state=""></lock>				1											
Crimp strength					1										
Durability						2									
Contact resistance with force on the cable							2								
Vibration								2							
Shock									2						
Thermal shock										3					
Humidity(Steady state)											3				
Salt water spray												2			
High temperature life													2		
Solder ability														1	
Soldering heat Resistance															1
Sample Quantity	10	5	10	10	10	10	10	10	10	10	10	10	10	10	10

XNumbers indicate test sequences in which tests are performed.

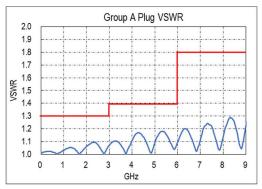
Table.2 Test Result

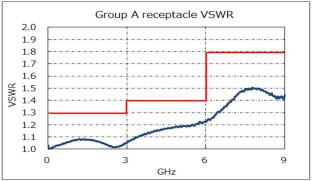
Group	Test items		Specification	Number of	Unit	AVE.	MAX.	MIN.	S	Judgement				
Gloup		Measurements		samples	Offic	AVL.	IVI/VX.	IVIIIV.		Judgemen				
Α	Dielectric w	ithstanding voltage												
		Initial	Spec: No creeping discharge	, flashover, no ins	sulator br	eakdown	shall occu	r.						
			-	10	-	No abnor	mality			Pass				
В	VSWR													
	Plug							_		_				
		0.1∼3.0GHz	1.3 MAX.	5	-	1.093	1.11	1.07	0.009	Pass				
		3.0 ~ 6.0GHz	1.5 MAX.	5	-	1.175	1.22	1.14	0.021	Pass				
		6.0∼9.0GHz	1.9 MAX.	5	-	1.286	1.35	1.22	0.031	Pass				
	Recepta	acle												
		0.1 ~ 3.0GHz	1.3 MAX.	5	-	1.085	1.09	1.08	0.006	Pass				
		3.0 ~ 6.0GHz	1.4 MAX.	5	-	1.233	1.27	1.18	0.033	Pass				
		6.0∼9.0GHz	1.8 MAX.	5	-	1.515	1.60	1.41	0.068	Pass				
	•		•	•		•		•	•	•				
С	Unmating force													
	Total force <unlock state=""></unlock>													
		Initial	5 MIN.	10	N	16.11	17.4	14.8	0.77	Pass				
		30 cycles	3 MIN.	10	N	11.04	11.9	10.2	0.56	Pass				
	Inner co	ntact						•		•				
		Initial	0.15 MIN.	10	N	0.369	0.39	0.35	0.014	Pass				
		30 cycles	0.10 MIN.	10	N	0.230	0.25	0.22	0.011	Pass				
			•	•				•						
D	Un-mating f	force <lock state=""></lock>	20 MIN.	10	N	36.89	38.0	35.9	0.88	I Door				
		IIIIuai	ZU IVI IIV.	10	IN	30.09	30.0	33.9	0.00	Pass				
E	Crimp stren	ath .												
	<u> </u>	-	15N MIN.	10	N	22.68	23.9	21.2	0.84	Pass				
F	Durability													
		resistance of main co	ntact											
		Initial	20 MAX.	40		5.53	6.5	4.3	0.72	Pass				
		After testing	25 MAX.	10	mΩ	6.52	7.5	5.7	0.62	Pass				
	Contact	resistance of ground of		j l				<u> </u>		1				
		Initial	10 MAX.	40	0	4.87	6.1	4.1	0.73	Pass				
		After testing	15 MAX.	10	mΩ	5.66	7.4	4.3	0.87	Pass				

Group	Test items		Specification	Number of	Unit	AVE.	MAX.	MIN.	S	Judgement
Gloup		Measurements	Specification	samples	Ullit	AVE.	IVIAN.	IVIIIN.	3	Judgemen
G	Contact resi	stance with force on the c	able							ļ.
	Contact	resistance of main contac	t							
		Initial	20 MAX.	10	m0	5.53	6.4	4.6	0.61	Pass
		After testing	25 MAX.	10	mΩ	6.19	7.2	5.3	0.70	Pass
	Contact	resistance of ground cont	act	•		•	•			•
		Initial	10 MAX.	10	mΩ	4.99	5.9	4.3	0.59	Pass
		After testing	15 MAX.		11122	6.07	8.2	4.7	1.25	Pass
	Electrica	al discontinuity	•			•				•
		Spec: No creeping disch	arge, flashover, no insulator brea	kdown shall o	ccur.					
		After testing	-	10	-	No abnor	mality			Pass
	Appeara	nce	•							
		Initial	No abnormality adversely affecting	10		No abnor	mality			Pass
		After testing	the performance shall occur.	10	-	No abnormality				Pass
		•								
Н	Vibration									
	Contact	resistance of main contac	t							
		Initial	20 MAX.	40	_	5.65	6.5	5.2	0.47	Pass
		After testing	25 MAX.	10	mΩ	6.39	7.6	5.5	0.80	Pass
	Contact	resistance of ground cont	act	1		1			ļ	
		Initial	10 MAX.	1		4.84	5.3	4.2	0.40	Pass
		After testing	15 MAX.	10	mΩ	6.72	7.8	6.1	0.51	Pass
	Electrica	al discontinuity								
			arge, flashover, no insulator brea	kdown shall o	ccur.					
		After testing	-	10	-	No abnor	mality			Pass
	Appeara					1				<u> </u>
	'''	Initial	No abnormality adversely affecting	40		No abnor	mality			Pass
		After testing	the performance shall occur.	10	-	No abnor				Pass
				<u> </u>		1	<u>-</u>			L
J	Shock									
		resistance of main contac	t							
		Initial	20 MAX.	1		4.73	5.5	4.2	0.44	Pass
		After testing	25 MAX.	10	mΩ	6.70	7.9	5.0	0.90	Pass
	Contact	resistance of ground cont								
		Initial	10 MAX.			4.37	4.9	4.0	0.31	Pass
		After testing	15 MAX.	10	mΩ	6.36	6.8	6.0	0.28	Pass
	Electrica	al discontinuity	1			1 2.00	1		1	1
l			arge, flashover, no insulator brea	kdown shall o	ccur					
1				ao mi onan o	Jour.					
			T	10	_	No ahno	mality			Pass
	Anneara	After testing	-	10	-	No abnor	mality			Pass
	Appeara	After testing	T	10	-	No abnor	•			Pass

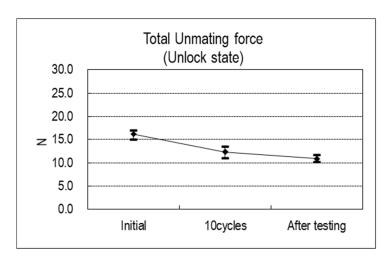
Group	Test items		Specification	Number of	Unit	AVE.	MAX.	MIN.	s	Judgement
Gloup		Measurements	Орсстватоп	samples	Offic	AVE.	IVI/VX.	IVIII V.		dagement
K	Thermal sho	ock								
	Contact	resistance of main contac	t							
		Initial	20 MAX.	10	mΩ	4.98	5.5	4.6	0.38	Pass
		After testing 25 MAX.] '	11122	6.70	7.9	5.8	0.81	Pass	
	Contact	resistance of ground cont	act		-					
		Initial	10 MAX.	10	mΩ	4.64	5.1	4.2	0.33	Pass
		After testing	15 MAX.] 10	11122	4.98	5.4	4.6	0.20	Pass
	Insulatio	n residence		•	•	•	•			•
		Initial	500MΩ MIN.	10	МΩ	10,000M	ΩMIN.			Pass
		After testing	100MΩ MIN.	1 10	10177	10,000M	ΩMIN.			Pass
	Appeara	nce		•		•				
		Initial	No abnormality adversely affecting	40		No abno	mality			Pass
		After testing	the performance shall occur.	10	-	No abno	Pass			
	<u> </u>	-				1				
L	Humidity(Ste	eady State)								
	Contact	resistance of main contac	t							
		Initial	20 MAX.	40		5.61	6.1	4.4	0.56	Pass
		After testing	25 MAX.	10	mΩ	6.08	6.6	5.6	0.34	Pass
	Contact	resistance of ground cont	act	1	<u>I</u>	1	I			
		Initial	10 MAX.			4.95	5.2	4.7	0.17	Pass
		After testing	15 MAX.	10	mΩ	6.08	6.8	5.6	0.33	Pass
	Insulatio	n residence								
		Initial	500MΩ MIN.			10,000M	ΩMIN.			Pass
		After testing	100MΩ MIN.	10	МΩ	10,000M	ΩMIN.			Pass
	Appeara					,				
		Initial	No abnormality adversely affecting			No abno	mality			Pass
		After testing	the performance shall occur.	10	-	No abno				Pass
	<u> </u>	J 3	,		<u> </u>					
М	Salt water sp	oray								
		resistance of main contac	t							
		Initial	20 MAX.			6.08	6.8	5.6	0.33	Pass
		After testing	25 MAX.	10	mΩ	6.98	8.6	6.0	0.73	Pass
	Contact	resistance of ground cont			<u> </u>	1	ļ		<u> </u>	ļ
		Initial	10 MAX.			4.99	5.3	4.6	0.21	Pass
		After testing	15 MAX.	10	mΩ	5.72	6.8	5.1	0.51	Pass
	Appeara		l	1	<u> </u>	1	1		<u> </u>	I
		Initial	No abnormality adversely affecting			No abno	mality			Pass
		After testing	the performance shall occur.	10	-	No abnor	,			Pass
L		1	1				- 7			. 300

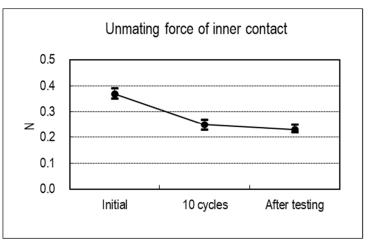
Group	Test items Measurements		Charifostian	Number of	Unit	AVE.	MAX.	MINI	S	ludaamaa		
Group			Specification	samples	Unit	AVE.	IVIAA.	MIN.	8	Judgemen		
N	High Temper	rature Life	•	<u>'</u>				•		•		
	Contact resistance of main contact											
		Initial	20 MAX.	10	mΩ	4.83	5.6	4.2	0.54	Pass		
	[After testing	25 MAX.		11122	6.42	8.1	5.0	0.97	Pass		
	Contact re	esistance of ground c	ontact									
		Initial	10 MAX.	10	mΩ	4.96	5.3	4.4	0.25	Pass		
		After testing	15 MAX.] 10]	11177	6.28	7.1	5.4	0.55	Pass		
	Appearan	се		•		•	•	•		•		
		Initial	No abnormality adversely affecting	10	_	No abnor	mality	Pass				
	[After testing	the performance shall occur.	10	_	No abnor	mality			Pass		
	lo-14											
Р	Solder ability		of the dipped surface shall be even	lywat								
	I			<u>. </u>	_	No abnor	mality			Pass		
	I	After testing		10	-	No abnor	mality			Pass		
Q	<u> </u>			<u>. </u>	-	No abnor	mality			Pass		
Q	<u> </u>	After testing		<u>. </u>	-	No abnor	mality			Pass		
Q	Reflow solder Appearan	After testing ring heat resistance ce		10	-	No abnor	mality			Pass		



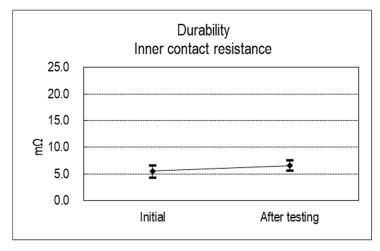


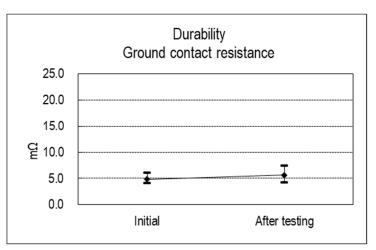
(Graph 1) VSWR



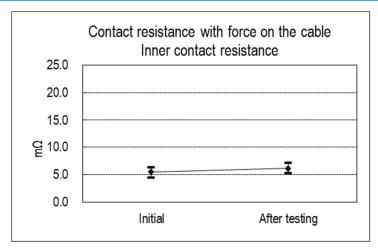


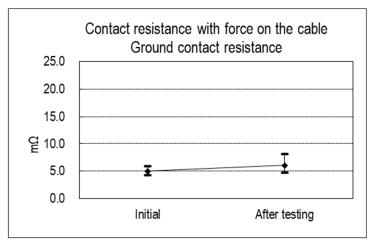
(Graph 2) Unmating force



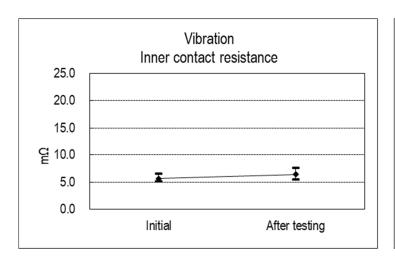


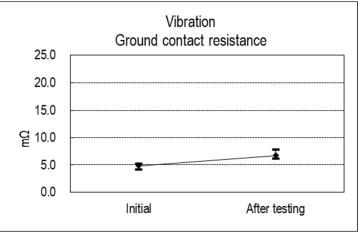
(Graph 3) Durability



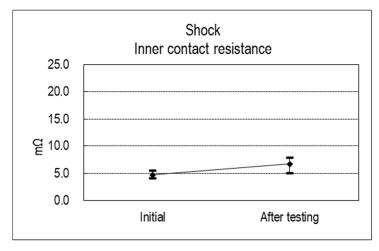


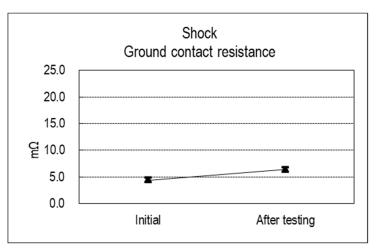
(Graph 4) Cable Retention Force



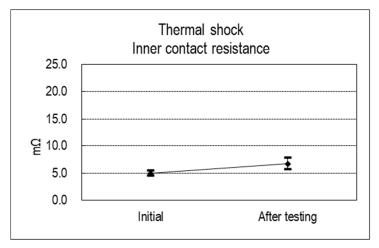


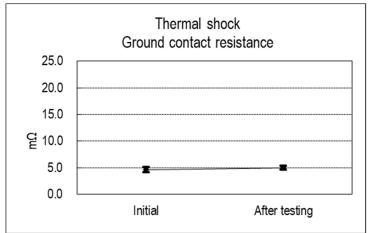
(Graph 5) Vibration



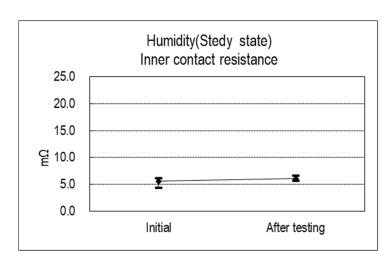


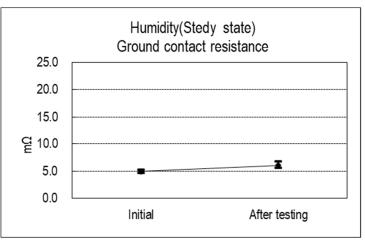
(Graph 6) Shock



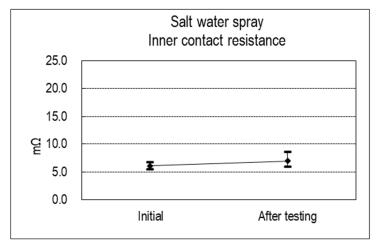


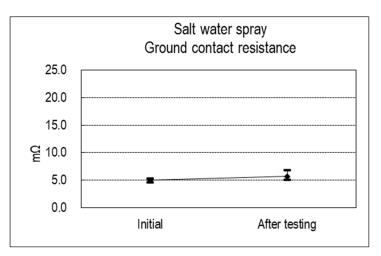
Graph 7) Thermal Shock



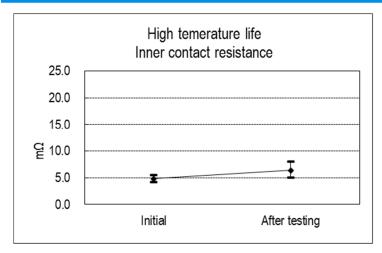


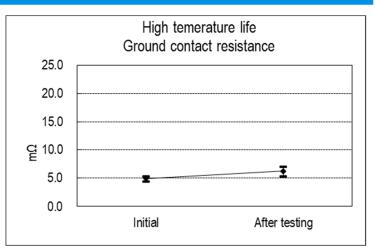
(Graph 8) Humidity (Steady State)





(Graph 9) Salt Water Spray





(Graph 10) High Temperature Life